



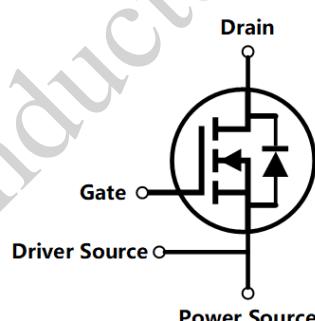
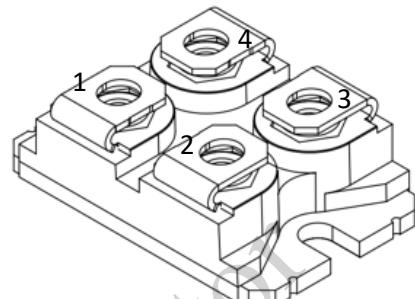
## SiC MOS I3M12016MB N-Channel Enhancement Mode

### Features

- High Blocking Voltage with Low  $R_{DS(\text{on})}$
- Low Switching Losses
- Internal Isolation
- High Speed Switching
- Easy to Drive and Parallel

### Applications

- High-frequency Switching Application
- DC/DC Converters
- Motor Drives
- Solar Inverters
- EV Charging
- UPS



Drain	3
Power Source	4
Driver Source	1
Gate	2

### Standards Benefits

- Improve System Efficiency
- Improve Power Density
- Reduce System Size



### Order Information

Part Number	Package	Marking
I3M12016MB	SOT-227	I3M12016MB



## Contents

<b>Features</b> .....	1
Applications.....	1
Standards Benefits.....	1
Order Information.....	1
<b>Contents</b> .....	2
1. Maximum Ratings.....	3
2. Electrical Characteristics.....	4
3. Reverse Diode Characteristics .....	6
4. Thermal Characteristics .....	6
5. Typical Performance .....	7
6. Package Outlines .....	12



## 1. Maximum Ratings

At  $T_J = 25^\circ\text{C}$ , unless specified otherwise

Parameter	Symbol	Value	Unit	Test Conditions
Drain - Source Voltage	$V_{DS\max}$	1200	V	$V_{GS}=0\text{V}$ $I_D = 100\mu\text{A}$
Gate - Source Voltage (Dynamic)	$V_{GS\max}$	-8 / +21	V	AC ( $f > 1\text{Hz}$ )
Gate - Source Voltage(static) turn-on gate voltage turn-off gate voltage	$V_{GS,\text{on}}$ $V_{GS,\text{off}}$	+15/+18 -3	V	Static
Continuous Drain Current	$I_D$	90	A	$V_{GS} = 18\text{V}$ $T_C = 25^\circ\text{C}$ $T_J = 175^\circ\text{C}$
		68		$V_{GS} = 18\text{V}$ $T_C = 100^\circ\text{C}$ $T_J = 175^\circ\text{C}$
Power Dissipation	$P_D$	300	W	
Operating Junction Temperature	$T_J$	-40 To +175	°C	
Storage Temperature	$T_{\text{stg}}$	-40 To +150	°C	



## 2. Electrical Characteristics

At  $T_J = 25^\circ\text{C}$ , unless specified otherwise (Per Position)

Parameter	Symbol	Value			Unit	Test Conditions
		Min.	Typ.	Max.		
Drain-Source Breakdown Voltage	$V_{(\text{BR})\text{DSS}}$	1200	/	/	V	$V_{GS} = 0\text{V}$ $I_D = 100\mu\text{A}$
Gate Threshold Voltage	$V_{GS(\text{th})}$	1.8	2.6	/	V	$V_{DS} = V_{GS}$ $I_D = 20\text{mA}$
Reverse Bias Drain Current	$I_{\text{DSS}}$	/	2	200	$\mu\text{A}$	$V_{GS} = 0\text{V}$ $V_{DS} = 1200\text{V}$
Gate-Source Leakage Current	$I_{GSS}$	/	10	500	nA	$V_{GS} = 18\text{V}$ $V_{DS} = 0\text{V}$
Drain-Source On-State Resistance	$R_{DS(\text{on})}$	/	20	26	$\text{m}\Omega$	$V_{GS} = 15\text{V}$ $I_D = 50\text{A}$ $T_J = 25^\circ\text{C}$
		/	26	/		$V_{GS} = 15\text{V}$ $I_D = 50\text{A}$ $T_J = 175^\circ\text{C}$
		/	16	23		$V_{GS} = 18\text{V}$ $I_D = 50\text{A}$ $T_J = 25^\circ\text{C}$
		/	23	/		$V_{GS} = 18\text{V}$ $I_D = 50\text{A}$ $T_J = 175^\circ\text{C}$
Internal Gate Resistance	$R_{G(\text{int})}$	/	1.1	/	$\Omega$	$f = 1\text{MHz}$ $V_{AC} = 25\text{mV}$
Cross Stored Energy	$E_{\text{oss}}$	/	110	/	$\mu\text{J}$	$V_{DS} = 800\text{V}$ $f = 500\text{kHz}$
Input Capacitance	$C_{iss}$	/	7140	/	pF	$V_{GS} = 0\text{V}$ $V_{DS} = 800\text{V}$ $f = 500\text{kHz}$ $V_{AC} = 25\text{mV}$
Output Capacitance	$C_{oss}$	/	280	/	pF	



# I3M12016MB SiC MOS N-Channel Enhancement Mode

Parameter	Symbol	Value			Unit	Test Conditions
		Min.	Typ.	Max.		
Reverse Transfer Capacitance	$C_{rss}$	/	29	/	pF	
Gate to Source Charge	$Q_{gs}$	/	81	/	nC	$V_{DS} = 800V$ $I_{DS} = 50A$ $V_{GS} = -3 \text{ to } 18V$ $I_G = 5mA$
Gate to Drain Charge	$Q_{gd}$	/	80	/		
Total Gate Charge	$Q_g$	/	249	/		
Turn-on Energy	$E_{on}$	/	592	/	$\mu J$	$V_{DS} = 800V$ $I_{DS} = 50A$ $V_{GS} = -3V/18V$ $R_G = 1.0\Omega$ $L = 100\mu H$
Turn-off Energy	$E_{off}$	/	187	/		
Turn-On Delay Time	$T_{d(on)}$	/	25.8	/	ns	$V_{DS} = 800V$ $I_{DS} = 50A$ $V_{GS} = -3V/18V$ $R_G = 1.0\Omega$ $L = 100\mu H$
Rise Time	$T_r$	/	31.7	/		
Turn-Off Delay Time	$T_{d(off)}$	/	44.3	/		
Fall Time	$T_f$	/	15.4	/		



### 3. Reverse Diode Characteristics

At  $T_J = 25^\circ\text{C}$ , unless specified otherwise (Per Position)

Parameter	Symbol	Value		Unit	Test Conditions
		Typ.	Max.		
Diode Forward Voltage	$V_{SD}$	6.1	/	V	$V_{GS} = -3\text{V}$ $I_{SD} = 50\text{A}$ $T_J = 25^\circ\text{C}$
		3.9	/	V	$V_{GS} = -3\text{V}$ $I_{SD} = 50\text{A}$ $T_J = 175^\circ\text{C}$
Reverse Recover Time	$t_{rr}$	27	/	ns	$V_{GS} = -3/18\text{V}$ $I_{SD} = 50\text{A}$ $V_{DS} = 800\text{V}$ $d_i/d_t = 4100\text{A}/\mu\text{s}$ $R_G = 1.0\Omega$ $T_J = 25^\circ\text{C}$
Reverse Recovery Charge	$Q_{rr}$	1152	/	$\mu\text{C}$	
Peak Reverse Recovery Current	$I_{rrm}$	68	/	A	
Reverse Recovery Energy	$E_{RR}$	677	/	$\mu\text{J}$	

### 4. Thermal Characteristics

Parameter	Symbol	Value	Unit
Thermal Resistance from Junction to Case	$R_{\theta JC}$	0.50	$^\circ\text{C/W}$



## 5. Typical Performance

At  $T_J = 25^\circ\text{C}$ , unless specified otherwise

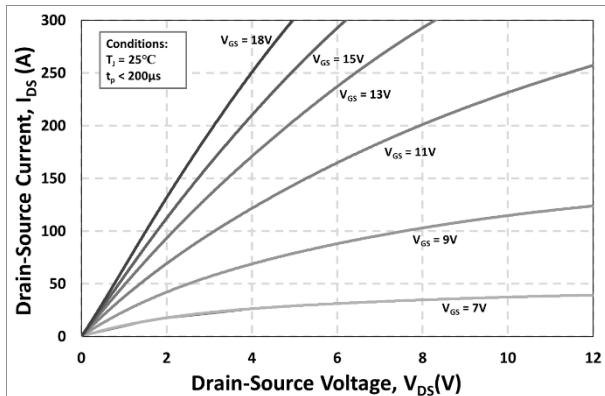


Figure 1. Output Characteristics  $T_J = 25^\circ\text{C}$

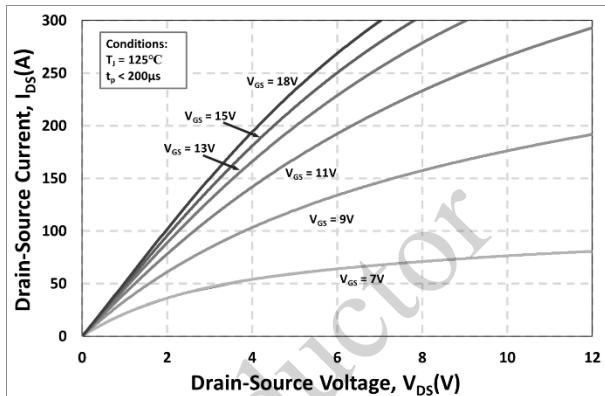


Figure 2. Output Characteristics  $T_J = 125^\circ\text{C}$

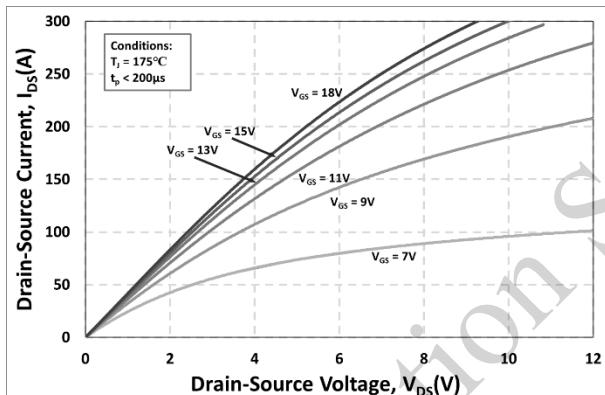


Figure 3. Output Characteristics  $T_J = 175^\circ\text{C}$

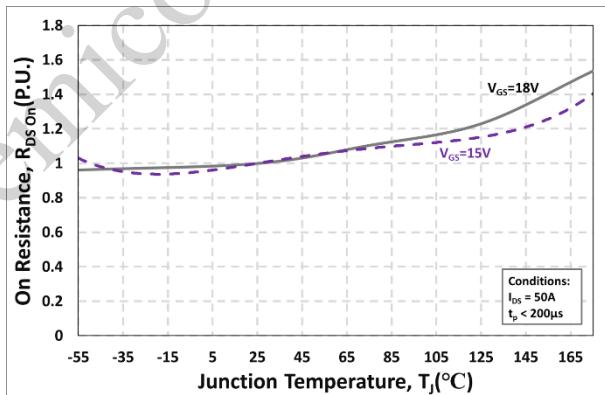


Figure 4. Normalized On-Resistance vs. Temperature

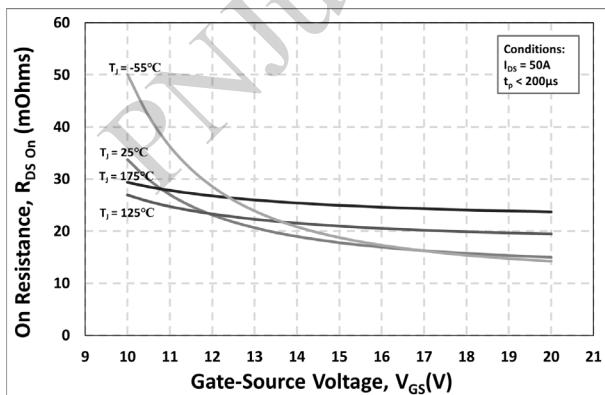


Figure 5. On-Resistance vs. Gate-Source Voltage

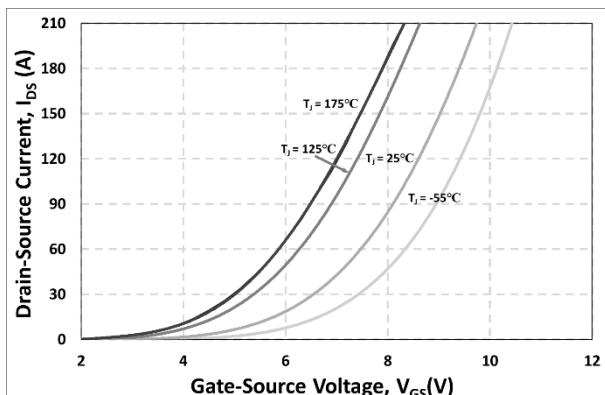


Figure 6. Transfer Characteristic for Various Junction Temperatures



# I3M12016MB SiC MOS N-Channel Enhancement Mode

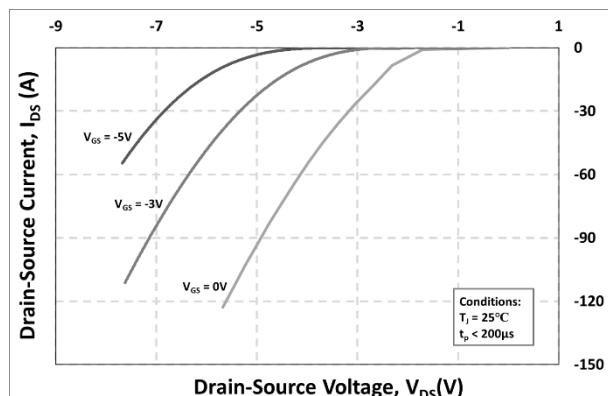


Figure 7. Body Diode Characteristic at  $25^\circ\text{C}$

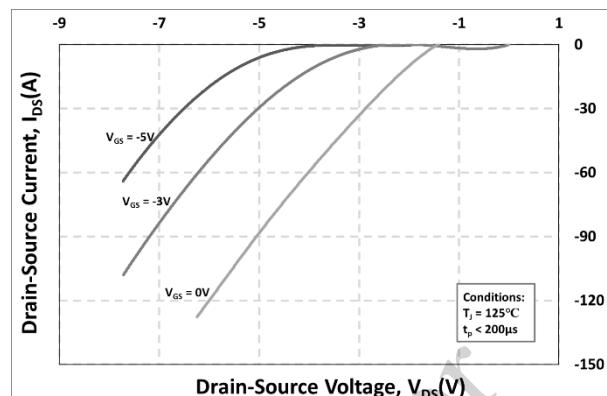


Figure 8. Body Diode Characteristic at  $125^\circ\text{C}$

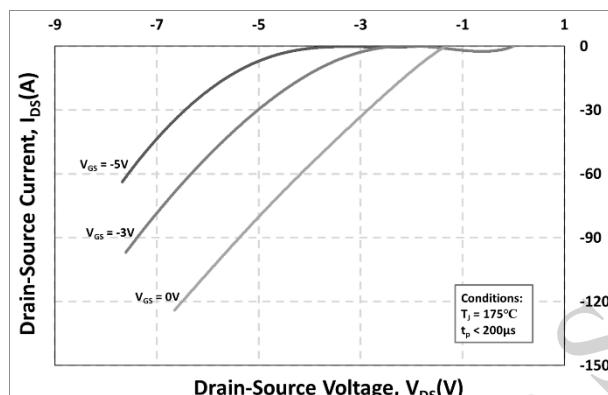


Figure 9. Body Diode Characteristic at  $175^\circ\text{C}$

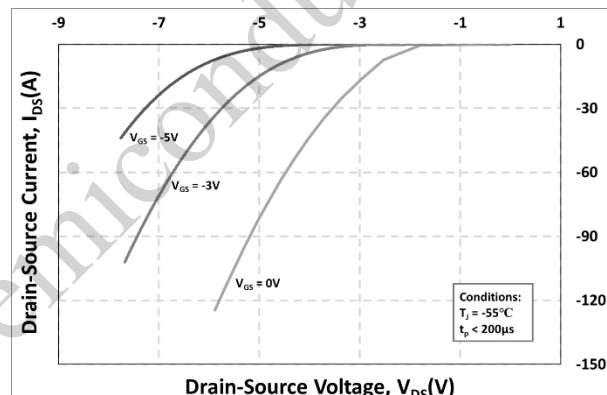


Figure 10. Body Diode Characteristic at  $-55^\circ\text{C}$

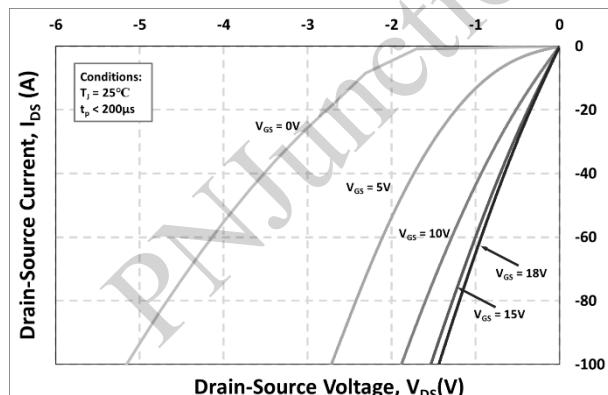


Figure 11. 3rd Quadrant Characteristic at  $25^\circ\text{C}$

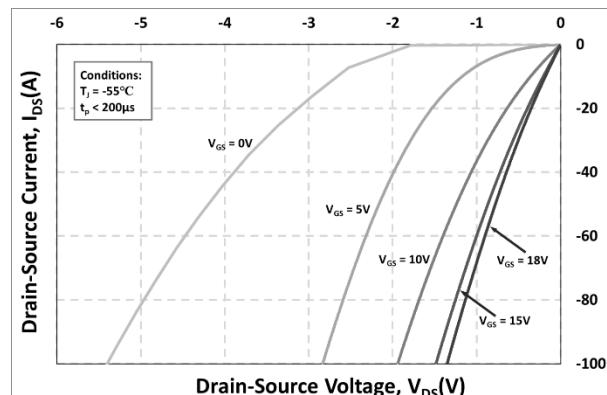


Figure 12. 3rd Quadrant Characteristic at  $-55^\circ\text{C}$



# I3M12016MB SiC MOS N-Channel Enhancement Mode

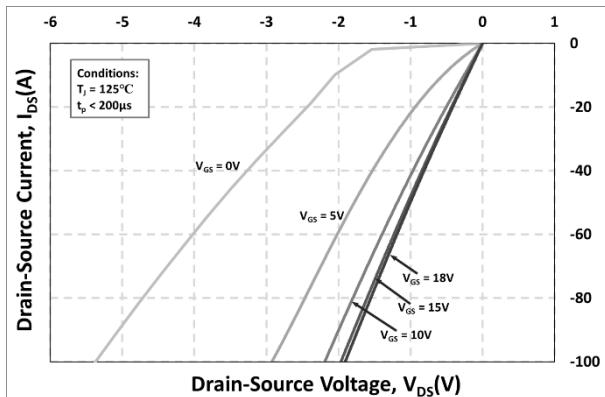


Figure 13. 3rd Quadrant Characteristic at 125°C

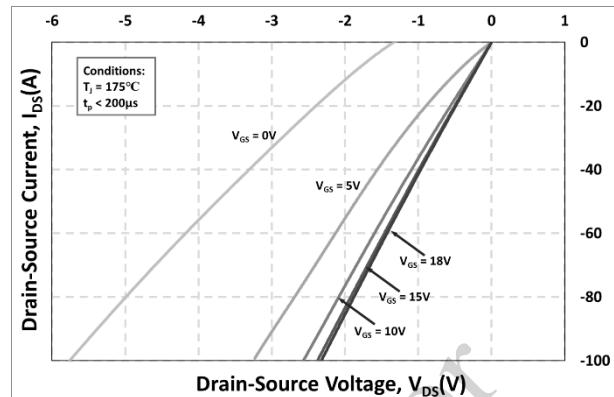


Figure 14. 3rd Quadrant Characteristic at 175°C

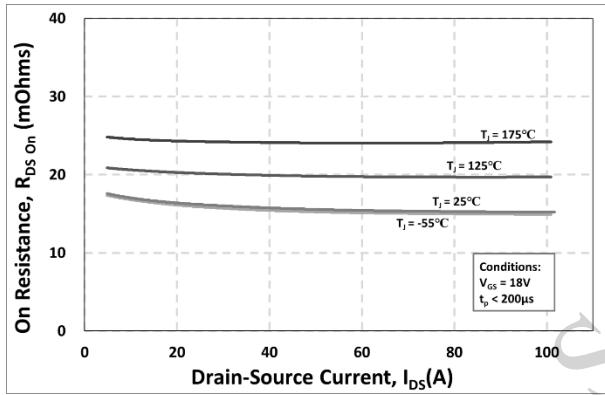


Figure 15. On-Resistance vs. Drain Current Various Temperatures

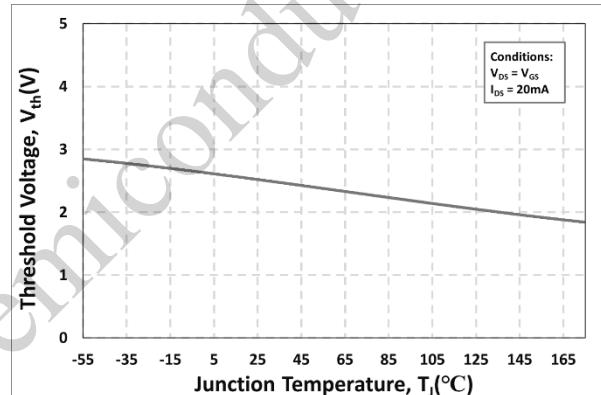


Figure 16. Threshold Voltage vs. Temperature

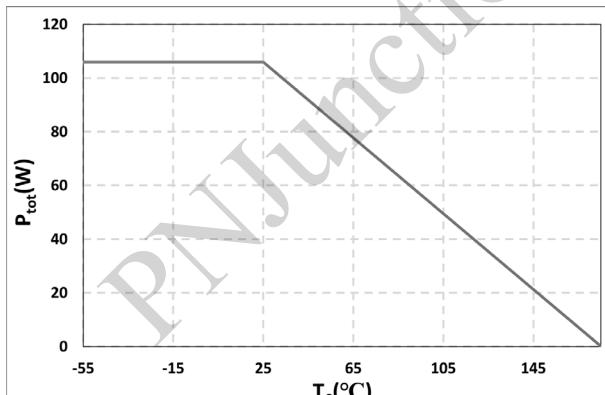


Figure 17. Maximum Power Dissipation Derating vs. Case Temperature

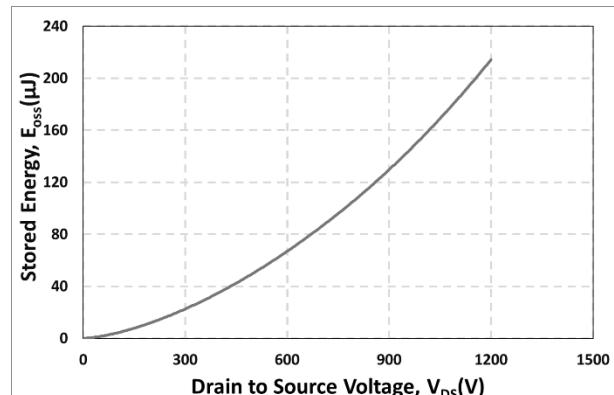
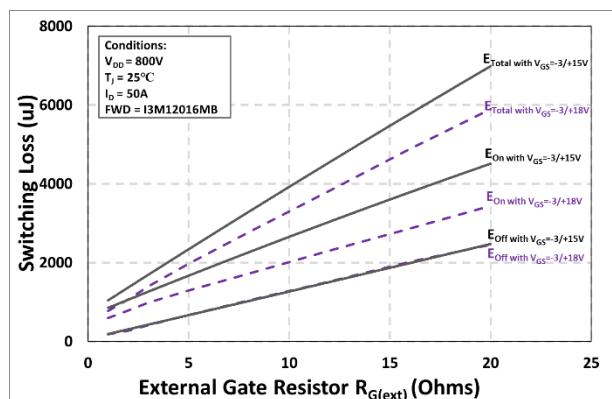
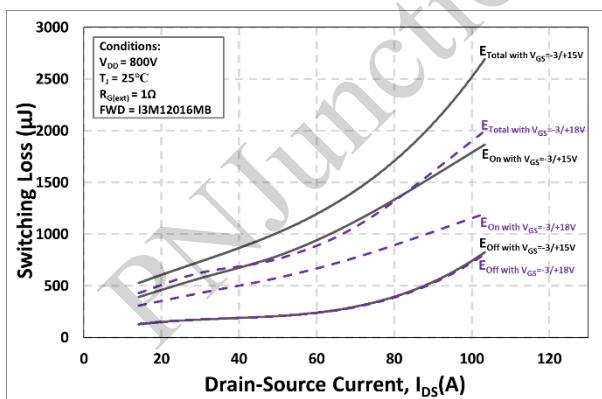
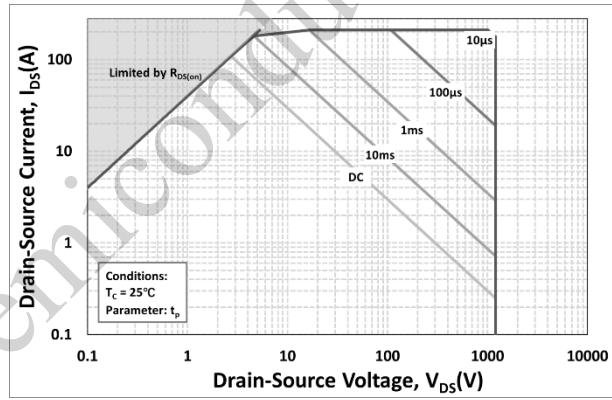
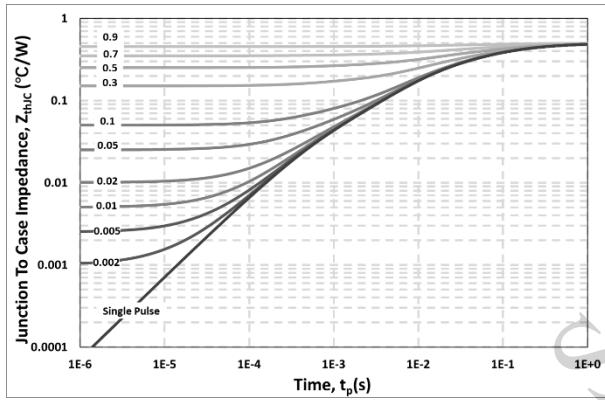
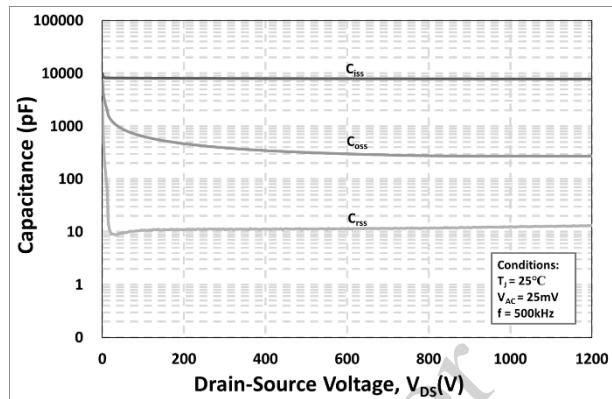
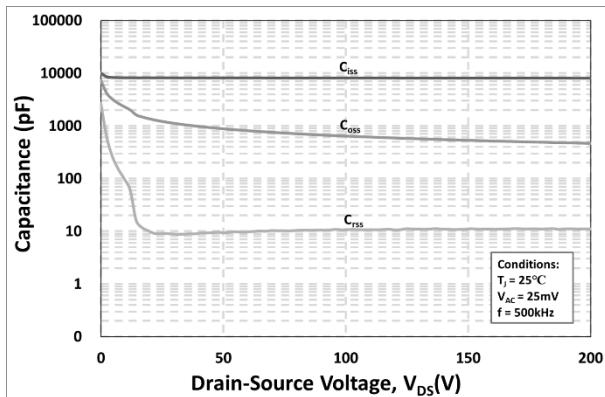


Figure 18. Output Capacitor Stored Energy



# I3M12016MB SiC MOS N-Channel Enhancement Mode





# I3M12016MB SiC MOS N-Channel Enhancement Mode

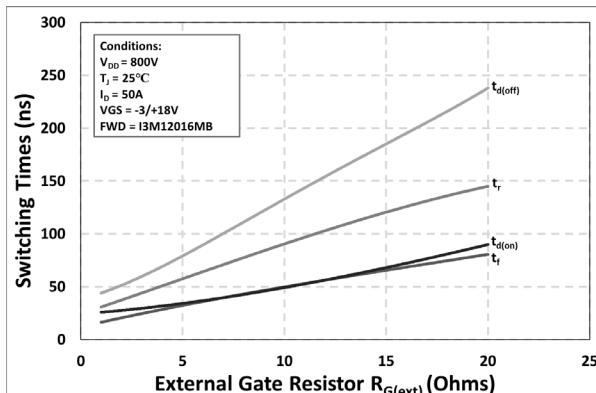


Figure 19. Switching Times vs. External Gate Resistance

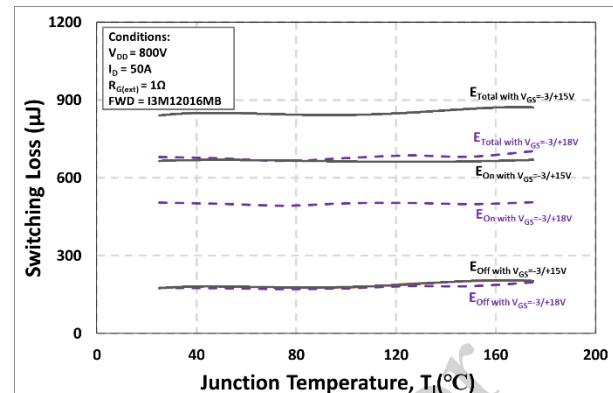
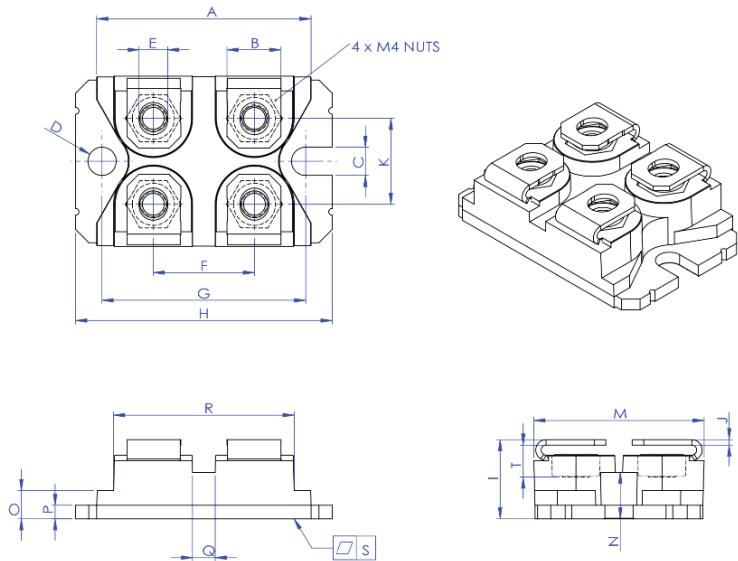


Figure 20. Clamped Inductive Switching Energy vs. Temperature



## 6. Package Outlines



Dimension	Millimeter		Typical
	Min	Max	
A	31.50	32.00	31.70
B	7.70	8.30	8.00
C	4.10	4.30	4.20
D	4.10	4.30	4.20
E	4.10	4.30	4.20
F	14.90	15.15	15.0
G	29.80	30.40	30.10
H	37.80	38.30	38.05
I	11.80	12.30	12.05
J	0.75	0.85	0.80
K	12.50	13.00	12.75
M	25.00	25.50	25.30
N	6.75	7.10	6.90
O	4.00	4.40	4.20
P	1.90	2.10	2.00
Q	3.20	3.60	3.40
R	26.60	27.00	26.80
S	-0.03	0.10	0.01
T	4.85	5.25	5.05

Drawing and Dimensions

PNJunction Semiconductor



## **Important Notice**

---

The information given in this document shall in no event be regarded as a guarantee of conditions or characteristics. With respect to any examples, hints or any typical values stated herein and/or any information regarding the application of the product, PN Junction hereby disclaims any and all warranties and liabilities of any kind, including without limitation warranties of non-infringement of intellectual property rights of any third party.

PN Junction reserves the right to make changes at any time to any products or information herein, without notice. "Typical" parameters which may be provided in PN Junction data sheets and/or specifications can and do vary in different applications and actual performance may vary over time. All operating parameters, including "Typical" must be validated for each customer application by customer's technical experts.

In addition, any information given in this document is subject to customer's compliance with its obligations stated in this document and any applicable legal requirements, norms and standards concerning customer's products and any use of the product of PN Junction in customer's applications. The data contained in this document is exclusively intended for technically trained staff. It is the responsibility of customer's technical departments to evaluate the suitability of the product for the intended application and the completeness of the product information given in this document with respect to such application.

For further information on the product, technology, delivery terms and conditions and prices please contact your nearest PN Junction office ([www.pnjsemi.com](http://www.pnjsemi.com)).

## **Warnings**

---

Due to technical requirements products may contain dangerous substances. For information on the types in question please contact your nearest PN Junction office.

Except as otherwise explicitly approved by PN Junction in a written document signed by authorized representatives of PN Junction, PN Junction's products may not be used in any applications where a failure of the product or any consequences of the use thereof can reasonably be expected to result in personal injury.